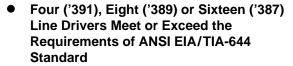
'LVDS389

SLLS362D – SEPTEMBER 1999 – REVISED MAY 2001

'LVDS387



- Designed for Signaling Rates[†] up to 630 Mbps With Very Low Radiation (EMI)
- Low-Voltage Differential Signaling With Typical Output Voltage of 350 mV and a 100- Ω Load
- **Propagation Delay Times Less Than 2.9 ns**
- **Output Skew Is Less Than 150 ps**
- Part-to-Part Skew Is Less Than 1.5 ns
- 35-mW Total Power Dissipation in Each **Driver Operating at 200 MHz**
- **Driver Is High Impedance When Disabled or** With $V_{CC} < 1.5 \text{ V}$
- SN65' Version Bus-Pin ESD Protection Exceeds 15 kV
- Packaged in Thin Shrink Small-Outline Package With 20-mil Terminal Pitch
- Low-Voltage TTL (LVTTL) Logic Inputs Are 5-V Tolerant

description

This family of four, eight, and sixteen differential line drivers implements the electrical characteristics of low-voltage differential signaling (LVDS). This signaling technique lowers the output voltage levels of 5-V differential standard levels (such as EIA/TIA-422B) to reduce the power, increase the switching speeds, and allow operation with a 3.3-V supply rail. Any of the sixteen current-mode drivers will deliver a minimum differential output voltage magnitude of 247 mV into a 100-Ω load when enabled.

DBT PACKAGE (TOP VIEW)				D	GG P	ACKAGE
((TOP \	/IEW))		(TOF	P VIEW)
GND [10	38	A1Y	GND [┧╸╵	
V _{CC}	2	37	A1Z	V _{CC} [2	63 A1Z
GND	3	36	A2Y	V _{CC} [3	62 A2Y
ENA 🛚	4	35	A2Z	GND [4	61 A2Z
A1A	5	34	A3Y	ENA [5	60 A3Y
A2A 🛮	6	33	A3Z	A1A [6	₅₉] A3Z
АЗА [7	32	A4Y	A2A [7	58 🛚 A4Y
A4A [8	31	A4Z	A3A [8	57 🛮 A4Z
GND [9	30]NC	A4A	9	56 B1Y
Vcc [10	29]NC	ENB [10	55 B1Z
GND [11	28]NC	B1A [11	54 B2Y
B1A [12	27	B1Y	B2A [7	53 B2Z
B2A 🏻	13	26	B1Z	B3A [1	52 B3Y
ВЗА 🛚	14	25	B2Y	B4A [7	51 B3Z
B4A [15	24	B2Z	GND [15	50 B4Y
ENB [16	23	B3Y	V _{CC} [16	49 B4Z
GND [17	22	B3Z	V _{CC} [17	48 C1Y
V _{CC}	18	21	B4Y	GND [C1A [18	47 C1Z
GND [19	20	B4Z	C1A [19	46 C2Y 45 C2Z
				C2A [20 21	45 C2Z 44 C3Y
	'LVD			C4A [22	43 C3Z
	PW F			ENC [23	43 0 032 42 C4Y
(TOP \	/IEVV)		D1A [24	41 C4Z
EN1,2 [1 C	ر 16] 1Y	D2A [25	40 D1Y
1A	2	15	2	D3A [26	39 D1Z
2A [3		2Y	D4A	27	38 D2Y
Vcc [4		2Z	END [28	37 D2Z
GND [5	12		GND [29	36 D3Y
3A [6	11	3Z	V _{CC} [30	35 D3Z
4A [7	10] 4Y	Vcc [31	34 🛭 D4Y
EN3,4 [8	9	4Z	GND [32	33 D4Z
					Щ	

The intended application of this device and signaling technique is for point-to-point and multidrop baseband data transmission over controlled impedance media of approximately 100 Ω . The transmission media can be printed-circuit board traces, backplanes, or cables. The large number of drivers integrated into the same substrate, along with the low pulse skew of balanced signaling, allows extremely precise timing alignment of clock and data for synchronous parallel data transfers. When used with the companion 16- or 8-channel receivers, the SN65LVDS386 or SN65LVDS388, over 300 million data transfers per second in single-edge clocked systems are possible with very little power. (Note: The ultimate rate and distance of data transfer is dependent upon the attenuation characteristics of the media, the noise coupling to the environment, and other system characteristics.)



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

† Signaling rate, 1/t, where t is the minimum unit interval and is expressed in the units bits/s (bits per second)

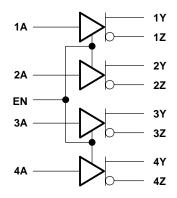


description (continued)

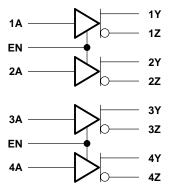
When disabled, the driver outputs are high impedance. Each driver input (A) and enable (EN) have an internal pulldown that will drive the input to a low level when open circuited.

The SN65LVDS387, SN65LVDS389, and SN65LVDS391 are characterized for operation from –40°C to 85°C. The SN75LVDS387, SN75LVDS389, and SN75LVDS391 are characterized for operation from 0°C to 70°C.

logic diagram (positive logic)



(1/4 of 'LVDS387 or 1/2 of 'LVDS389 shown)



('LVDS391 shown)

AVAILABLE OPTIONS

PART NUMBER†	TEMPERATURE RANGE	NO. OF DRIVERS	BUS-PIN ESD
SN65LVDS387DGG	–40°C to 85°C	16	15 kV
SN75LVDS387DGG	0°C to 70°C	16	4 kV
SN65LVDS389DBT	–40°C to 85°C	8	15 kV
SN75LVDS389DBT	0°C to 70°C	8	4 kV
SN65LVDS391D	–40°C to 85°C	4	15 kV
SN75LVDS391D	0°C to 70°C	4	4 kV
SN65LVDS391PW	–40°C to 85°C	4	15 kV
SN75LVDS391PW	0°C to 70°C	4	4 kV

This package is available taped and reeled. To order this packaging option, add an R suffix to the part number (e.g., SN65LVDS387DGGR).

DRIVER FUNCTION TABLE

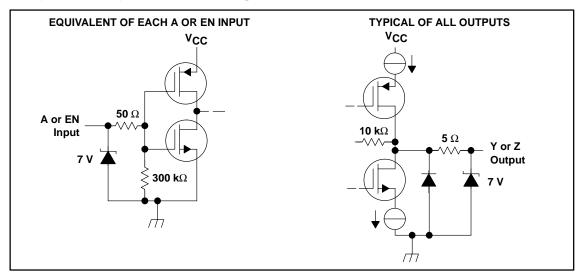
INPUT	ENABLE	OUTPUTS		
Α	EN	Y	Z	
Н	Н	Н	L	
L	Н	L	Н	
Х	L	Z	Z	
OPEN	Н	L	Н	

H = high-level, L = low-level, X = irrelevant,

Z = high-impedance (off)



equivalent input and output schematic diagrams



absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage range, V _{CC}	0.5 V to 4 V
Input voltage range: Inputs	0.5 V to 6 V
Y or Z	0.5 V to 4 V
Electrostatic discharge: SN65' (Y, Z, and GND)	Class 3, A:15 kV, B: 500 V
SN75' (Y, Z, and GND)	Class 3, A:4 kV, B: 400 V
Continuous power dissipation	(see Dissipation Rating Table)
Storage temperature range	65°C to 150°C
Lead temperature 1,6 mm (1/16 in) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

DISSIPATION RATING TABLE

PACKAGE	T_A ≤ 25°C	DERATING FACTOR [‡] ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
D	950 mW	7.6 mW/°C	608 mW	494 mW
DBT	1071 mW	8.5 mW/°C	688 mW	556 mW
DGG	2094 mW	16.7 mW/°C	1342 mW	1089 mW
PW	774 mW	6.2 mW/°C	496 mW	402 mW

[‡]This is the inverse of the junction-to-ambient thermal resistance when board-mounted (low-k) and with no air flow.

recommended operating conditions

		MIN	NOM	MAX	UNIT
Supply voltage, V _{CC}		3	3.3	3.6	V
High-level input voltage, V _{IH}					V
Low-level input voltage, V _{IL}				0.8	V
Operating free cir temperature T.	SN75'	0		70	°C
Operating free-air temperature, T _A	SN65'	-40		85	°C



NOTES: 1. All voltage values, except differential I/O bus voltages, are with respect to network ground terminal.

^{2.} Tested in accordance with MIL-STD-883C Method 3015.7.

SN65LVDS387, SN75LVDS387, SN65LVDS389 SN75LVDS389, SN65LVDS391, SN75LVDS391 HIGH-SPEED DIFFERENTIAL LINE DRIVERS

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electrical characteristics over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CO	MIN	TYP [†]	MAX	UNIT	
IVODI	Differential output voltage magnitude	R_L = 100 Ω , , See Figure 1 and Figure 2		247	340	454	
Δ V _{OD}	Change in differential output voltage magnitude between logic states			-50		50	mV
V _{OC(SS)}	Steady-state common-mode output voltage			1.125		1.375	V
ΔV _{OC} (SS)	Change in steady-state common-mode output voltage between logic states	See Figure 3		-50		50	mV
V _{OC(PP)}	Peak-to-peak common-mode output voltage	1			50	150	mV
		'LVDS387	Enabled,		85	95	
	Supply current	'LVDS389	$R_L = 100 \Omega$,		50	70	mA
		'LVDS391	$V_{IN} = 0.8 \text{ V or } 2 \text{ V}$		20	26	
Icc		'LVDS387			0.5	1.5	
		'LVDS389	Disabled, V _{IN} = 0 V or V _{CC}		0.5	1.5	
		'LVDS391	T VIN - O V OI VCC		0.5	1.3	
lн	High-level input current	V _{IH} = 2 V			3	20	μΑ
I _I L	Low-level input current	V _{IL} = 0.8 V			2	10	μΑ
	Chart singuit autout aumant	V_{OY} or $V_{OZ} = 0$ V				±24	mA
los	Short-circuit output current	V _{OD} = 0 V			±12	mA	
loz	High-impedance output current	$V_O = 0 \text{ V or } V_{CC}$				±1	μΑ
lO(OFF)	Power-off output current	V _{CC} = 1.5 V,	V _O = 2.4 V			±1	μΑ
C _{IN}	Input capacitance	V _I = 0.4 sin (4E6πt) +	0.5 V		5		pF
СО	Output capacitance	V _I = 0.4 sin (4E6πt) + Disabled	0.5 V,		9.4		pF

[†] All typical values are at 25°C and with a 3.3-V supply.

switching characteristics over recommended operating conditions (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP†	MAX	UNIT
tPLH	Propagation delay time, low-to-high-level output		0.9	1.7	2.9	ns
t _{PHL}	Propagation delay time, high-to-low-level output		0.9	1.6	2.9	ns
t _r	Differential output signal rise time	$R_1 = 100 \Omega$	0.4	0.8	1	ns
t _f	Differential output signal fall time	$C_{L} = 10 \text{ pF},$	0.4	0.8	1	ns
t _{sk(p)}	Pulse skew (tpHL - tpLH)	See Figure 4		150	500	ps
t _{sk(o)}	Output skew [‡]			80	150	ps
tsk(pp)	Part-to-part skew§				1.5	ns
^t PZH	Propagation delay time, high-impedance-to-high-level output			6.4	15	ns
tPZL	Propagation delay time, high-impedance-to-low-level output	See Figure 5		5.9	15	ns
^t PHZ	Propagation delay time, high-level-to-high-impedance output			3.5	15	ns
t _{PLZ}	Propagation delay time, low-level-to-high-impedance output			4.5	15	ns

[†] All typical values are at 25°C and with a 3.3-V supply.



[‡]t_{sk(0)} is the magnitude of the time difference between the t_{PLH} or t_{PHL} of all drivers of a single device with all of their inputs connected together.

[§] t_{sk(pp)} is the magnitude of the difference in propagation delay times between any specified terminals of any two devices characterized in this data sheet when both devices operate with the same supply voltage, at the same temperature, and have the same test circuits.

PARAMETER MEASUREMENT INFORMATION

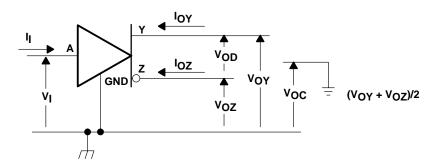


Figure 1. Voltage and Current Definitions

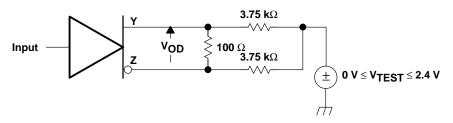
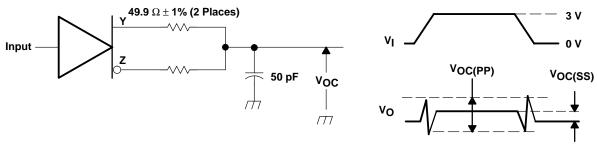
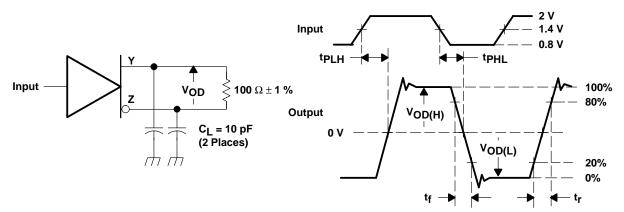


Figure 2. VOD Test Circuit



NOTE: All input pulses are supplied by a generator having the following characteristics: t_{Γ} or $t_{\Gamma} \le 1$ ns, pulse repetition rate (PRR) = 0.5 Mpps, pulse width = 500 ± 10 ns. C_L includes instrumentation and fixture capacitance within 0,06 m of the D.U.T. The measurement of V_{OC}(PP) is made on test equipment with a -3 dB bandwidth of at least 300 MHz.

Figure 3. Test Circuit and Definitions for the Driver Common-Mode Output Voltage

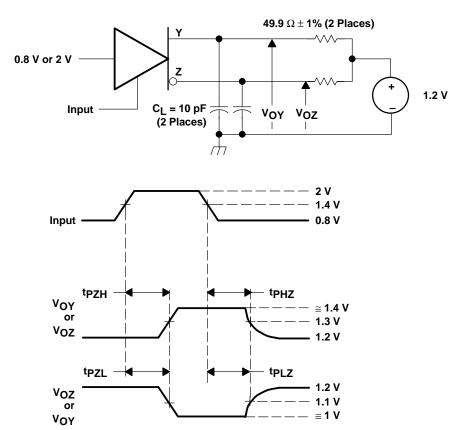


NOTE: All input pulses are supplied by a generator having the following characteristics: t_r or t_f ≤ 1 ns, pulse repetition rate (PRR) = 50 Mpps, pulse width = 10 ± 0.2 ns. C_I includes instrumentation and fixture capacitance within 0,06 m of the D.U.T.

Figure 4. Test Circuit, Timing, and Voltage Definitions for the Differential Output Signal



PARAMETER MEASUREMENT INFORMATION



NOTE: All input pulses are supplied by a generator having the following characteristics: t_{Γ} or $t_{f} \le 1$ ns, pulse repetition rate (PRR) = 0.5 Mpps, pulse width = 500 ± 10 ns. C_{L} includes instrumentation and fixture capacitance within 0,06 m of the D.U.T.

Figure 5. Enable and Disable Time Circuit and Definitions



TYPICAL CHARACTERISTICS

'LVDS391 SUPPLY CURRENT (RMS) vs

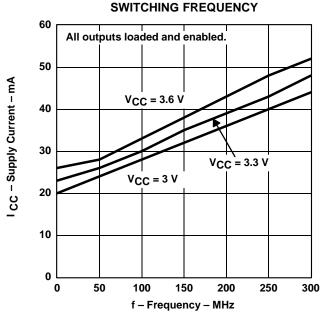
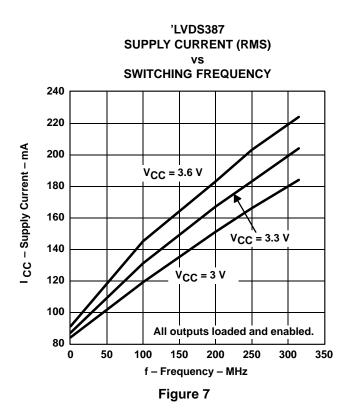


Figure 6



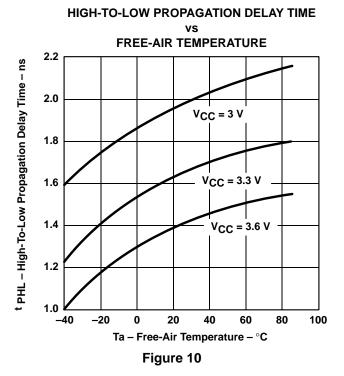
'LVDS389 **SUPPLY CURRENT (RMS) SWITCHING FREQUENCY** 110 100 I CC - Supply Current - mA 90 80 $V_{CC} = 3.6 V$ 70 V_{CC} = 3.3 V 60 $V_{CC} = 3 V$ 50 All outputs loaded and enabled. 40 50 0 100 150 200 250 300 f - Frequency - MHz

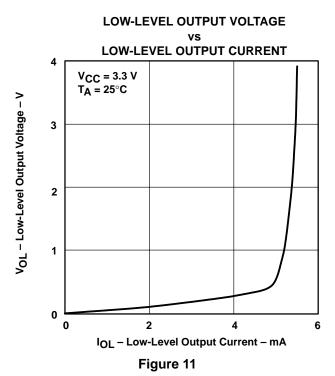
Figure 8

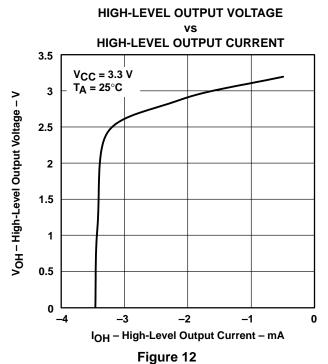


TYPICAL CHARACTERISTICS

LOW-TO-HIGH PROPAGATION DELAY TIME FREE-AIR TEMPERATURE 2.1 ^t PLH – Low-To-High Propagation Delay Time – ns 2.0 V_{CC} = 3.6 V 1.9 1.8 1.7 V_{CC} = 3 V 1.6 V_{CC} = 3.3 V 1.5 1.4 1.3 -40 100 -20 20 40 80 60 T_A - Free-Air Temperature - °C Figure 9







TYPICAL CHARACTERISTICS

OUTPUT VOLTAGE

t - Time - ns

Figure 13



APPLICATION INFORMATION

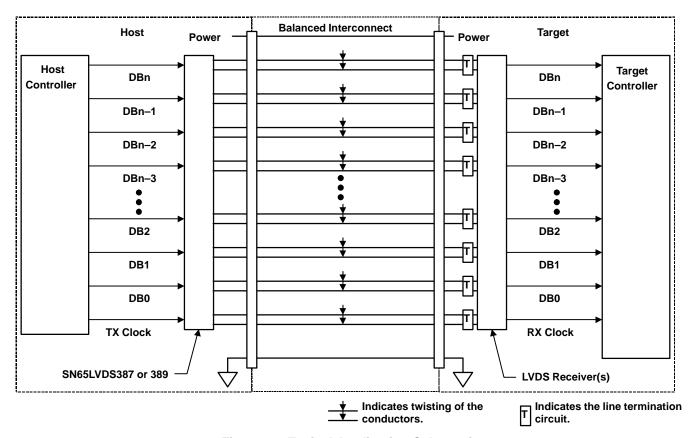


Figure 14. Typical Application Schematic

Signaling Rate vs Distance

The ultimate data transfer rate over a given cable or trace length involves many variables. Starting with the capabilities of this LVDS driver to reproduce a data pulse as short as 1.6 ns (a 630 Mbps signaling rate) with less than 500 ps of pulse distortion, any degradation of this pulse by the transmission media will necessarily reduce the timing margin at the receiving end of the data link.

The timing uncertainty induced by the transmission media is commonly referred to as jitter and comes from numerous sources. The characteristics of a particular transmission media can be quantified by using an eyepattern measurement such as shown in Figure 12, which shows about 340 ps of jitter or 20% of the data pulse width.



APPLICATION INFORMATION

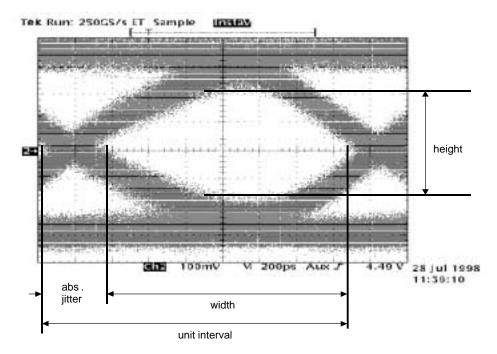


Figure 15. Typical LVDS Eyepattern

A generally accepted range of jitter at the receiver inputs that allows data recovery is 5% to 20% of the unit interval (data pulse width). Table 1 shows the signaling rate achieved on various cables and lengths at a 5% eyepattern jitter with a typical LVDS driver.

Table 1. Signaling Rates for Various Cables for 5% Eyepattern Jitter

LENGTH	CABLE [†]						
(m)	A (Mbps)	B (Mbps)	C (Mbps)	D (Mbps)	E (Mbps)	F (Mbps)	
1	240	200	240	270	180	230	
5	205	210	230	250	215	230	
10	180	150	195	200	145	180	

[†] Cable A: CAT 3, specified up to 16 MHz, no shield, outside conductor diameter (Ø) 0.52 mm

Cable B: CAT 5, specified up to 100 MHz, no shield, Ø 0.52 mm

Cable C: CAT 5, specified up to 100 MHz, taped over all shield, \varnothing 0.52 mm

Cable D: CAT 5 (exceeding CAT 5), specified up to 300 MHz, braided over all shield plus taped individual shield for any pair, \varnothing 0.64 mm (AWG22)

Cable E: CAT 5 (exceeding CAT 5), specified up to 350 MHz, \varnothing 0.64 mm (AWG22), no shield

Cable F: CAT 5 (exceeding CAT 5), specified up to 350 MHz, "self-shielded", Ø 0.64 mm (AWG22)

During synchronous parallel transfers, skew between the data and clock lines will also reduce the timing margin. This must be accounted for in the system timing budget. Fortunately, the low output skew of this LVDS driver will generally be a small portion of this budget.

other LVDS products

For other products and applications notes in the LVDS and LVDM product families visit our Web site at http://www.ti.com/sc/datatran.

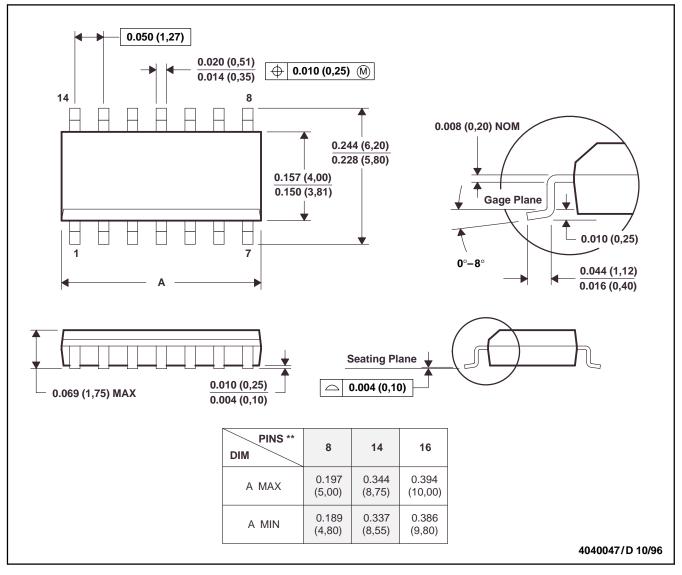


MECHANICAL DATA

D (R-PDSO-G**)

14 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0.006 (0,15).

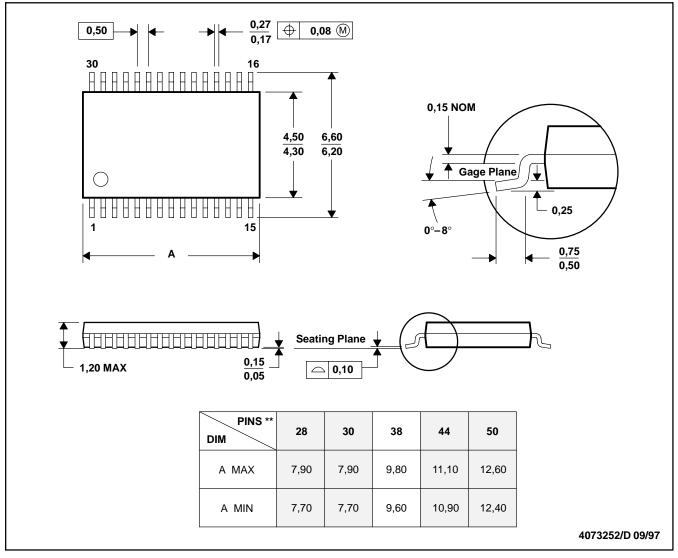
D. Falls within JEDEC MS-012

MECHANICAL DATA

DBT (R-PDSO-G**)

30 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion.

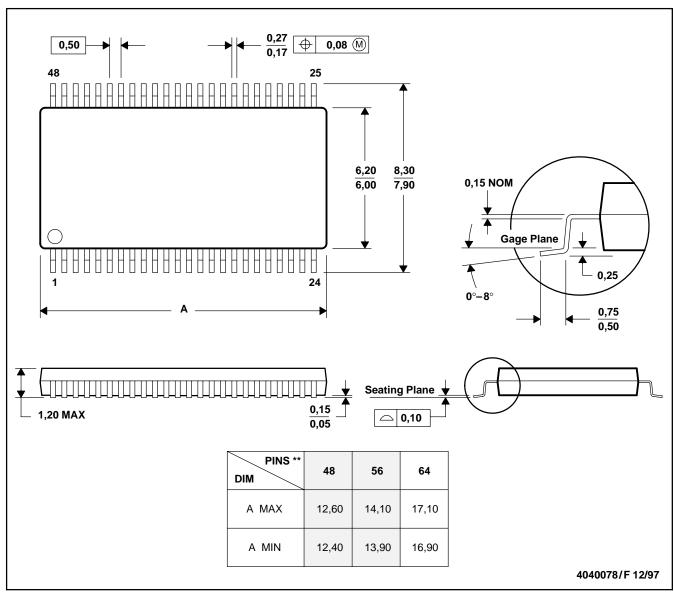
D. Falls within JEDEC MO-153

MECHANICAL DATA

DGG (R-PDSO-G**)

48 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold protrusion not to exceed 0,15.

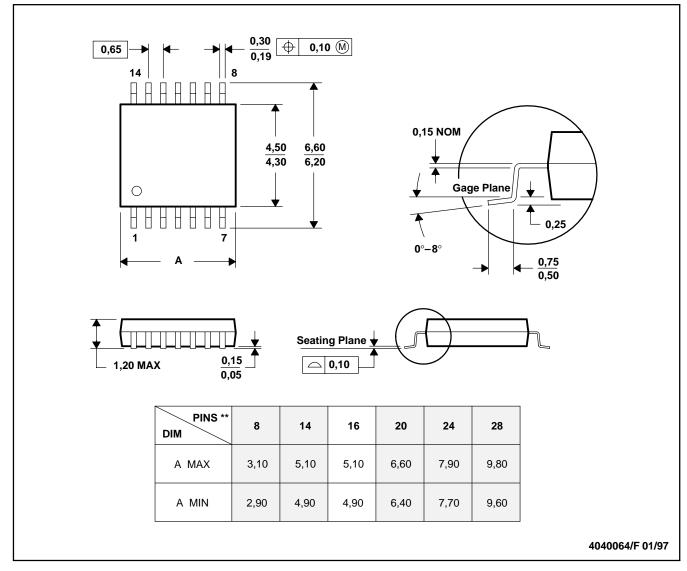
D. Falls within JEDEC MO-153

MECHANICAL DATA

PW (R-PDSO-G**)

14 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153





i.com 14-Mar-2005

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finisl	n MSL Peak Temp ⁽³⁾
SN65LVDS387DGG	ACTIVE	TSSOP	DGG	64	25	None	CU NIPDAU	Level-1-220C-UNLIM
SN65LVDS387DGGR	ACTIVE	TSSOP	DGG	64	2000	None	CU NIPDAU	Level-1-220C-UNLIM
SN65LVDS389DBT	ACTIVE	SM8	DBT	38	50	None	CU NIPDAU	Level-2-220C-1 YEAR
SN65LVDS389DBTG4	PREVIEW	SM8	DBT	38	50	None	Call TI	Call TI
SN65LVDS389DBTR	ACTIVE	SM8	DBT	38	2000	None	CU NIPDAU	Level-2-220C-1 YEAR
SN65LVDS389DBTRG4	PREVIEW	SM8	DBT	38	2000	None	Call TI	Call TI
SN65LVDS391D	ACTIVE	SOIC	D	16	40	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1YEAR/ Level-1-220C-UNLIM
SN65LVDS391DR	ACTIVE	SOIC	D	16	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1YEAR/ Level-1-220C-UNLIM
SN65LVDS391PW	ACTIVE	TSSOP	PW	16	90	None	CU NIPDAU	Level-1-220C-UNLIM
SN65LVDS391PWR	ACTIVE	TSSOP	PW	16	2000	None	CU NIPDAU	Level-1-220C-UNLIM
SN75LVDS387DGG	ACTIVE	TSSOP	DGG	64	25	None	CU NIPDAU	Level-1-220C-UNLIM
SN75LVDS387DGGR	ACTIVE	TSSOP	DGG	64	2000	None	CU NIPDAU	Level-1-220C-UNLIM
SN75LVDS389DBT	ACTIVE	SM8	DBT	38	50	None	CU NIPDAU	Level-2-220C-1 YEAR
SN75LVDS389DBTG4	ACTIVE	SM8	DBT	38	50	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
SN75LVDS389DBTR	ACTIVE	SM8	DBT	38	2000	None	CU NIPDAU	Level-2-220C-1 YEAR
SN75LVDS389DBTRG4	ACTIVE	SM8	DBT	38	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
SN75LVDS391D	ACTIVE	SOIC	D	16	40	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1YEAR/ Level-1-220C-UNLIM
SN75LVDS391DR	ACTIVE	SOIC	D	16	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1YEAR/ Level-1-220C-UNLIM
SN75LVDS391PW	ACTIVE	TSSOP	PW	16	90	None	CU NIPDAU	Level-1-220C-UNLIM
SN75LVDS391PWR	ACTIVE	TSSOP	PW	16	2000	None	CU NIPDAU	Level-1-220C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

None: Not yet available Lead (Pb-Free).

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean "Pb-Free" and in addition, uses package materials that do not contain halogens, including bromine (Br) or antimony (Sb) above 0.1% of total product weight.

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDECindustry standard classifications, and peak solder temperature.

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⁽²⁾ Eco Plan - May not be currently available - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.



PACKAGE OPTION ADDENDUM

14-Mar-2005

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